

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination 10/826,153 SCHER ET AL.	
		Examiner	Art Unit RUSSELL S. NEGIN	1631 Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Mahamuni et al. Spectroscopic and structural characterization of electrochemically grown ZnO quantum dots. Journal of Applied Physics, volume 85, 1999, pages 2861-2865.
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.